

30V Dual Asymmetric N-Channel Enhancement Mode MOSFET

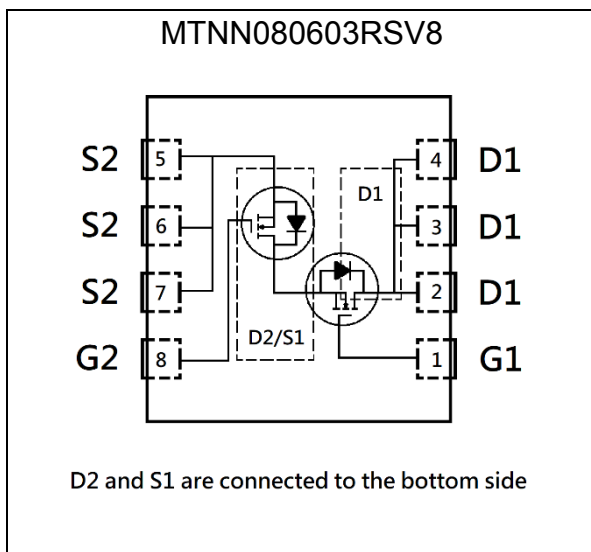
MTNN080603RSV8

Features

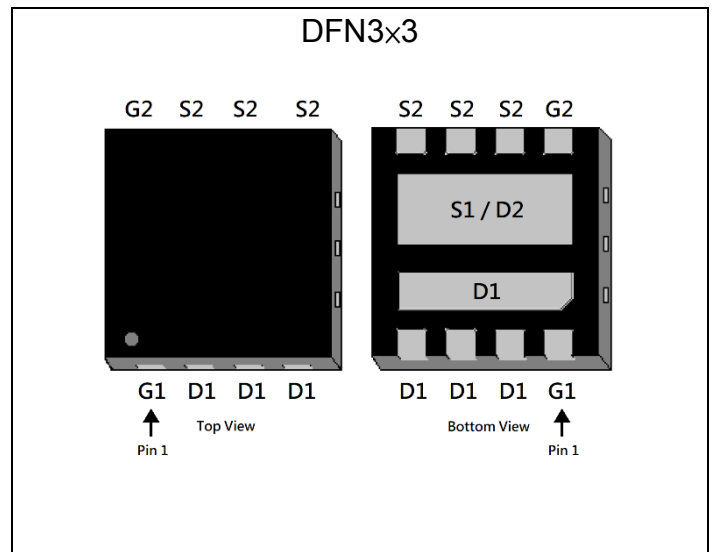
- High Current Capability
- Low On Resistance
- Fast Switching Characteristic
- Low Gate Charge
- RoHS compliant package

	Q1	Q2
BV_{DSS}	30V	30V
$I_D@V_{GS}=10V, T_C=25^\circ C$ (silicon limit)	38A	44A
$I_D@V_{GS}=10V, T_C=25^\circ C$ (package limit)	20A	30A
$I_D@V_{GS}=10V, T_A=25^\circ C$	8.6A	10A
$R_{DS(ON)}@V_{GS}=10V$	7.3mΩ	5mΩ
$R_{DS(ON)}@V_{GS}=4.5V$	11.5mΩ	7.5mΩ

Equivalent Circuit

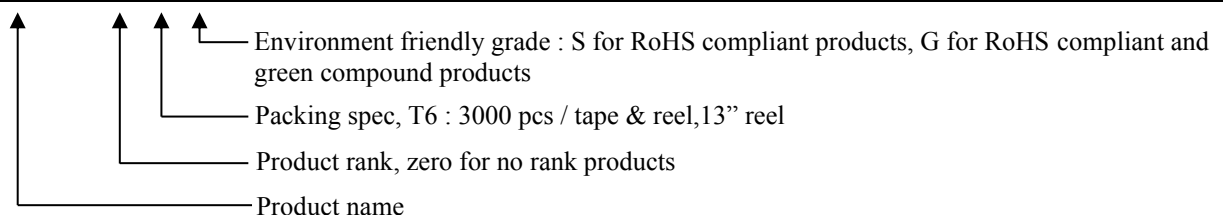


Outline



Ordering Information

Device	Package	Shipping
MTNN080603RSV8-0-T6-G	DFN3×3 (Pb-free lead plating and halogen-free package)	3000 pcs / Tape & Reel





Absolute Maximum Ratings (TA=25°C)

Parameter	Symbol	Limits		Unit	
		Q1	Q2		
Drain-Source Voltage	V _{DS}	30	30	V	
Gate-Source Voltage	V _{GS}	±20	±20		
Continuous Drain Current @ V _{GS} =10V, T _C =25°C (silicon limit) *a	I _D	38	44	A	
Continuous Drain Current @ V _{GS} =10V, T _C =25°C (package limit) *a		20	30		
Continuous Drain Current @ V _{GS} =10V, T _C =100°C *a		24	28		
Continuous Drain Current @ V _{GS} =10V, T _A =25°C *b		8.6	10		
Continuous Drain Current @ V _{GS} =10V, T _A =70°C *b		6.9	8		
Pulsed Drain Current *c	I _{DM}	80	120		
Continuous Body Diode Forward Current @ T _C =25°C *a	I _S	20	20		
Avalanche Current @ L=0.1mH	I _{AS}	13	15		
Avalanche Energy @ L=0.5mH	E _{AS}	12	16	mJ	
Total Power Dissipation	P _D	T _C =25°C *a	23	25	W
		T _C =100°C *a	9.2	10	
		T _A =25°C *b	1.1	1.2	
		T _A =70°C *b	0.7	0.8	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	-55~+150		°C

Thermal Data

Parameter	Symbol	Steady State		Unit
Thermal Resistance, Junction-to-case	R _{θJC}	5.4	5	°C/W
Thermal Resistance, Junction-to-ambient *b	R _{θJA}	110	100	

Note:

- *a. The power dissipation P_D is based on T_{J(MAX)}=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- *b. The value of R_{θJA} is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with T_A=25°C. The power dissipation P_D is based on R_{θJA} and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- *c. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and low duty cycles to keep initial T_J=25°C.



Q1 Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	10.2	-	S	V _{DS} =5V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =24V, V _{GS} =0V
R _{DS(ON)}	-	7.3	9.5	mΩ	V _{GS} =10V, I _D =12A
	-	11.5	16		V _{GS} =4.5V, I _D =9A
Dynamic					
C _{iss}	-	570	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	410	-		
C _{rss}	-	55	-		
R _g	-	0.6	-	Ω	f=1MHz
Q _g *1, 2	-	11	-	nC	V _{DS} =15V, I _D =12A, V _{GS} =10V
Q _{gs} *1, 2	-	2	-		
Q _{gd} *1, 2	-	2.2	-		
t _{d(ON)} *1, 2	-	7	-	ns	V _{DS} =15V, I _D =12A, V _{GS} =10V, R _{GS} =1Ω
t _r *1, 2	-	13	-		
t _{d(OFF)} *1, 2	-	20	-		
t _f *1, 2	-	5.4	-		
Source-Drain Diode					
V _{SD} *1	-	0.85	1.2	V	I _S =10A, V _{GS} =0V
t _{rr}	-	16	-	ns	I _F =10A, dI _F /dt=100A/μs
Q _{rr}	-	5.2	-	nC	

Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

*2. Independent of operating temperature



Q2 Characteristics (T_A=25°C, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
G _{FS}	-	11.2	-	S	V _{DS} =5V, I _D =10A
I _{GSS}	-	-	±100	nA	V _{GS} =±20V, V _{DS} =0V
I _{DSS}	-	-	1	μA	V _{DS} =24V, V _{GS} =0V
R _{DS(ON)}	-	5	6.5	mΩ	V _{GS} =10V, I _D =15A
	-	7.5	10.5		V _{GS} =4.5V, I _D =10A
Dynamic					
C _{iss}	-	750	-	pF	V _{DS} =15V, V _{GS} =0V, f=1MHz
C _{oss}	-	520	-		
C _{rss}	-	65	-		
R _g	-	0.7	-	Ω	f=1MHz
Q _g *1, 2	-	14	-	nC	V _{DS} =15V, I _D =15A, V _{GS} =10V
Q _{gs} *1, 2	-	3	-		
Q _{gd} *1, 2	-	3	-		
t _{d(ON)} *1, 2	-	9	-	ns	V _{DS} =15V, I _D =15A, V _{GS} =10V, R _{GS} =1Ω
t _r *1, 2	-	12.5	-		
t _{d(OFF)} *1, 2	-	24	-		
t _f *1, 2	-	6	-		
Source-Drain Diode					
V _{SD} *1	-	0.85	1.2	V	I _S =10A, V _{GS} =0V
t _{rr}	-	19	-	ns	I _F =10A, dI _F /dt=100A/μs
Q _{rr}	-	7	-	nC	

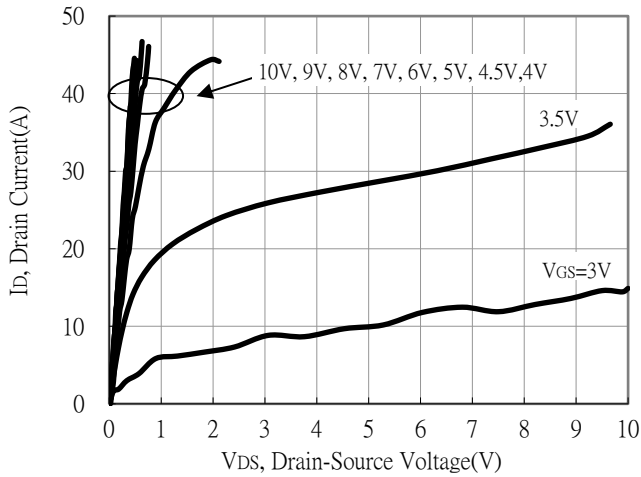
Note:

*1. Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

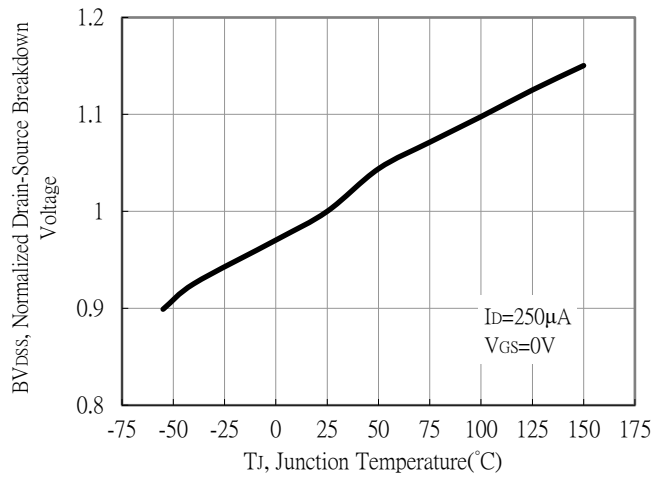
*2. Independent of operating temperature

Typical Characteristics : Q1(N-channel)

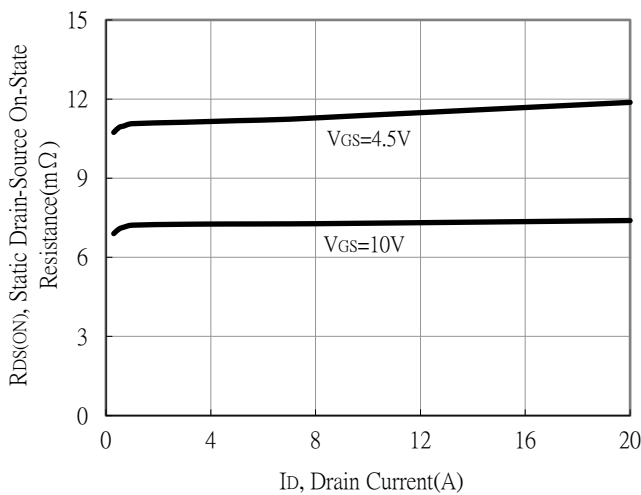
Typical Output Characteristics



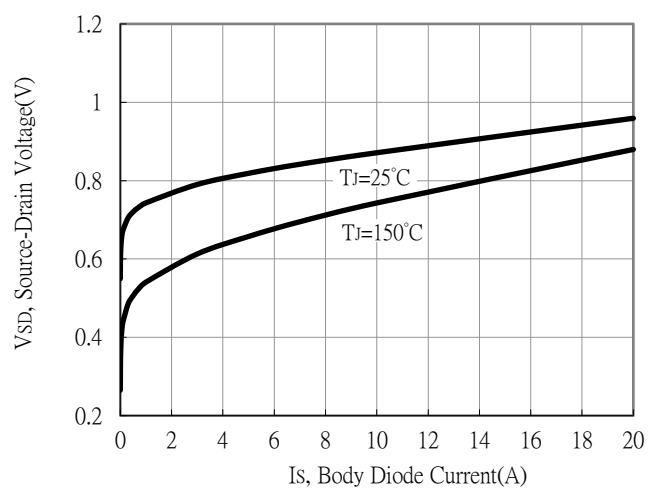
Breakdown Voltage vs Ambient Temperature



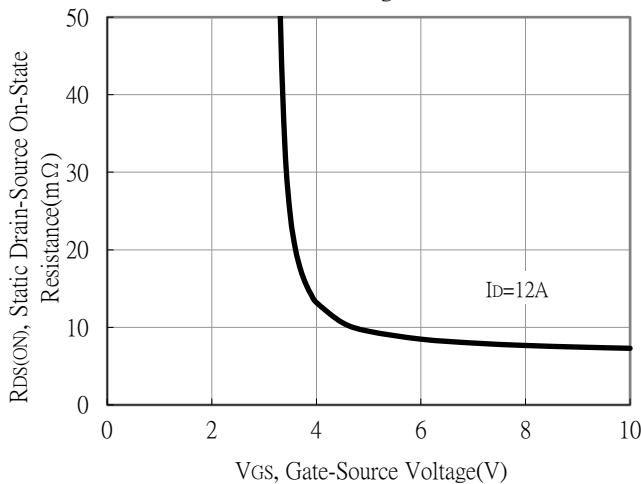
Static Drain-Source On-State resistance vs Drain Current



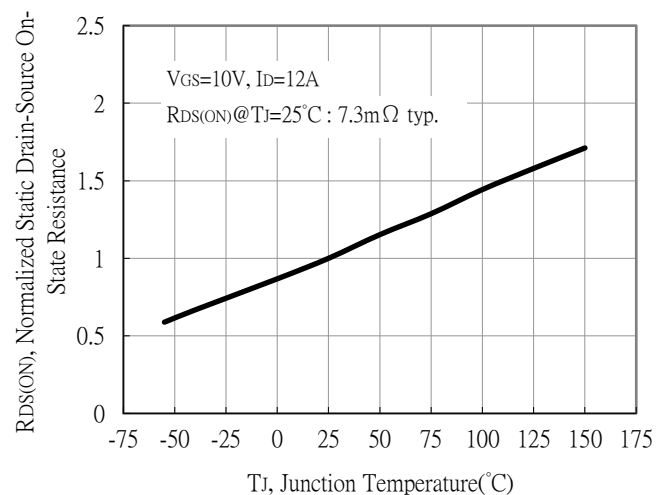
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

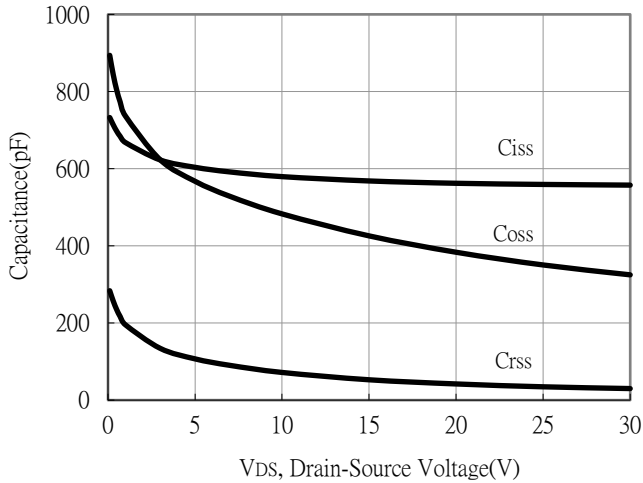


Drain-Source On-State Resistance vs Junction Temperature

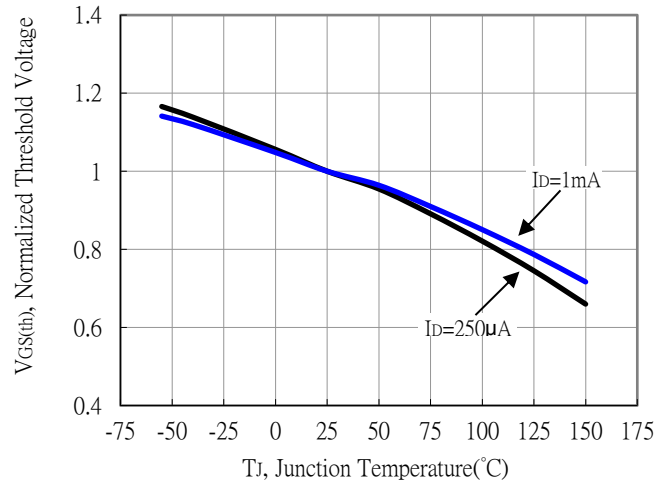


Typical Characteristics (Cont.) : Q1(N-channel)

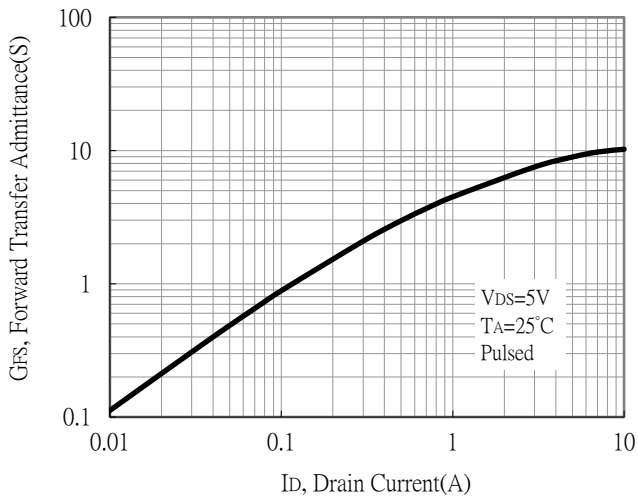
Capacitance vs Drain-to-Source Voltage



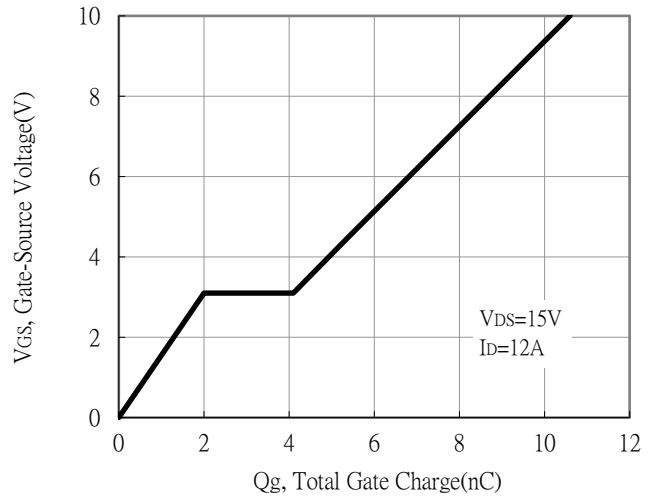
Threshold Voltage vs Junction Temperature



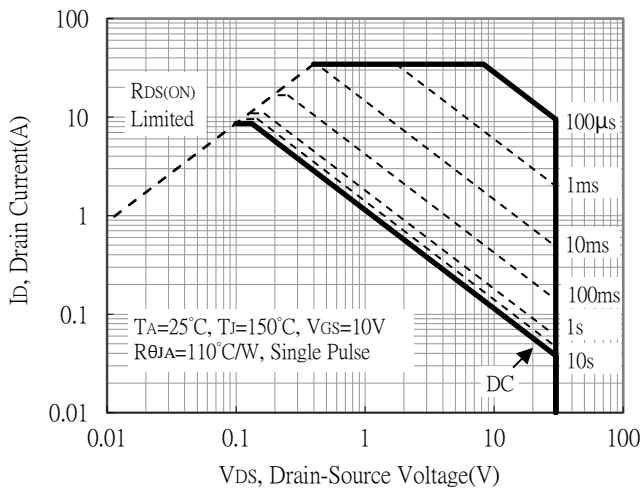
Forward Transfer Admittance vs Drain Current



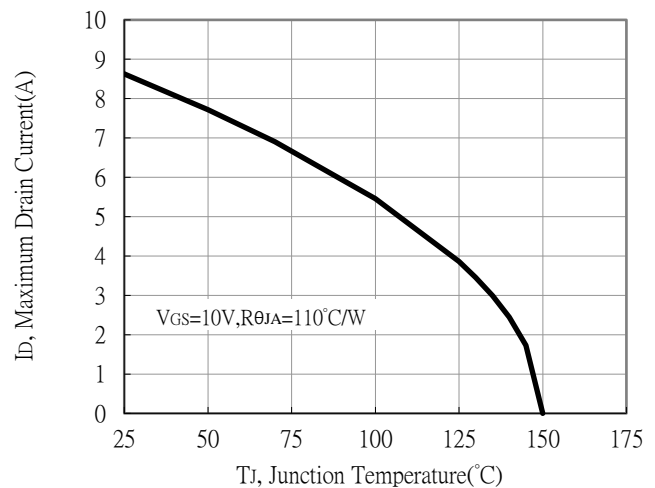
Gate Charge Characteristics



Maximum Safe Operating Area



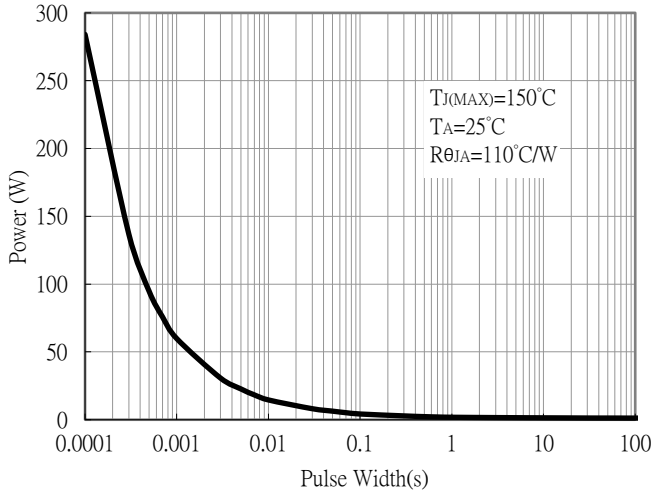
Maximum Drain Current vs Junction Temperature



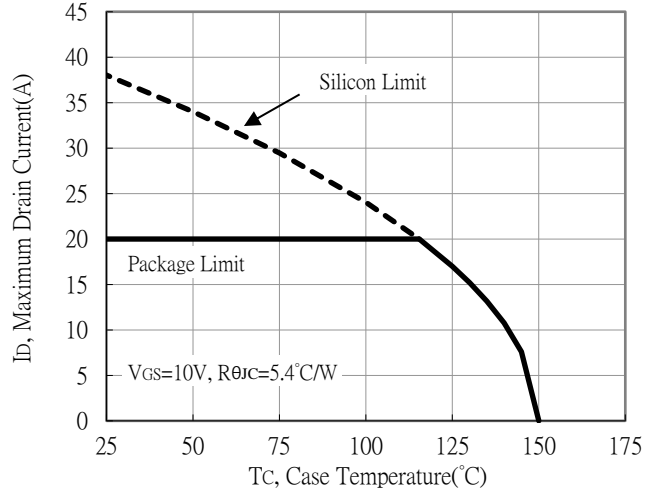


Typical Characteristics (Cont.) : Q1(N-channel)

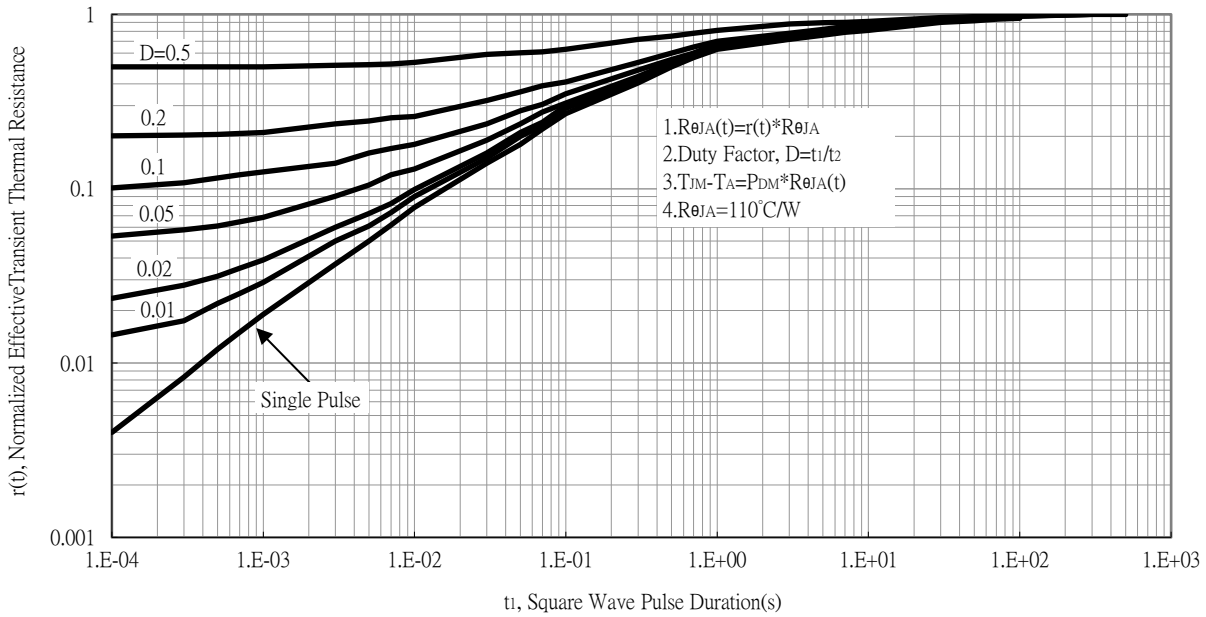
Single Pulse Power Rating, Junction to Ambient



Maximum Drain Current vs Case Temperature

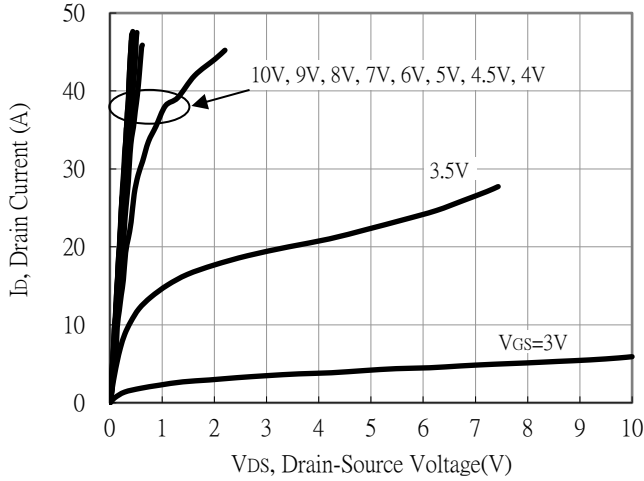


Transient Thermal Response Curves

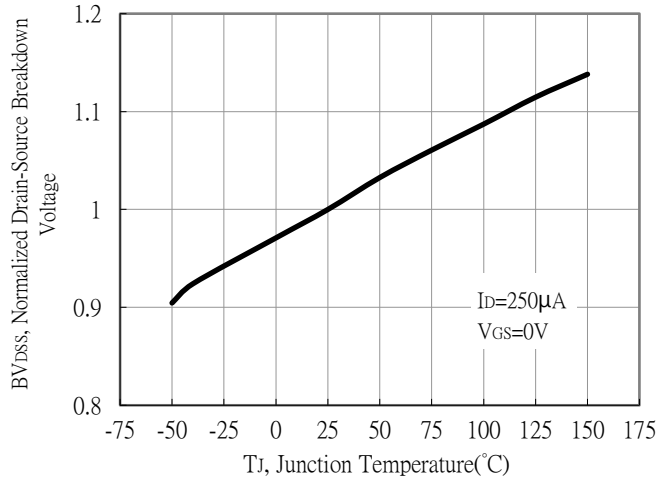


Typical Characteristics : Q2(N-channel)

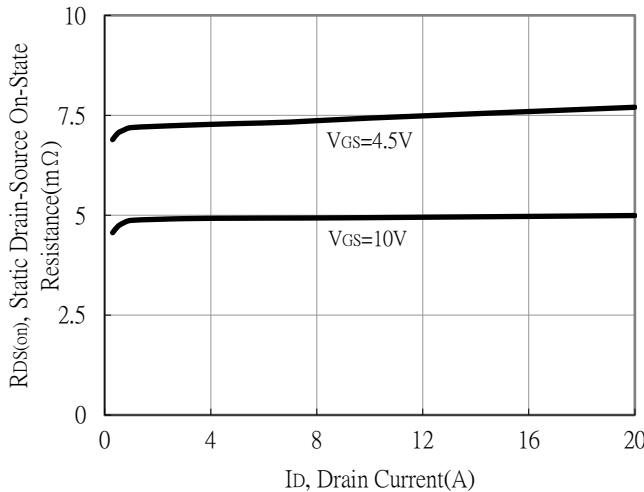
Typical Output Characteristics



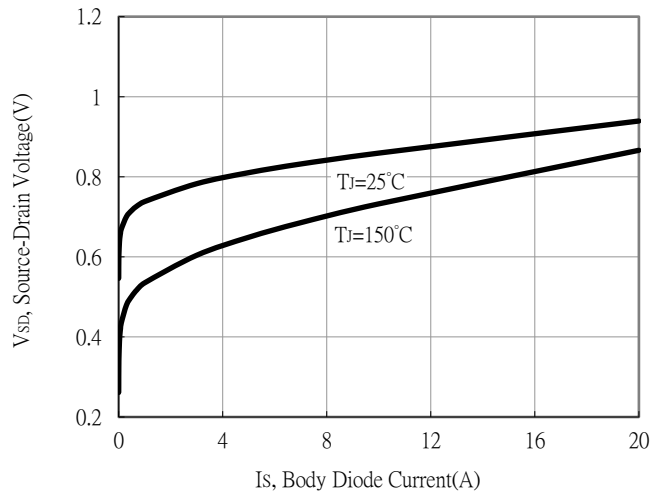
Breakdown Voltage vs Ambient Temperature



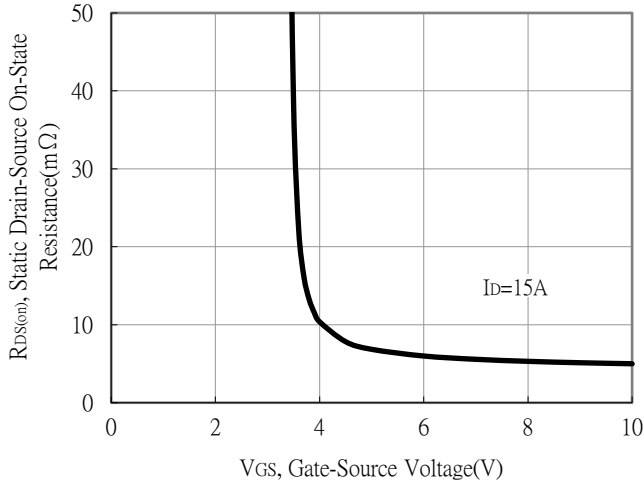
Static Drain-Source On-State resistance vs Drain Current



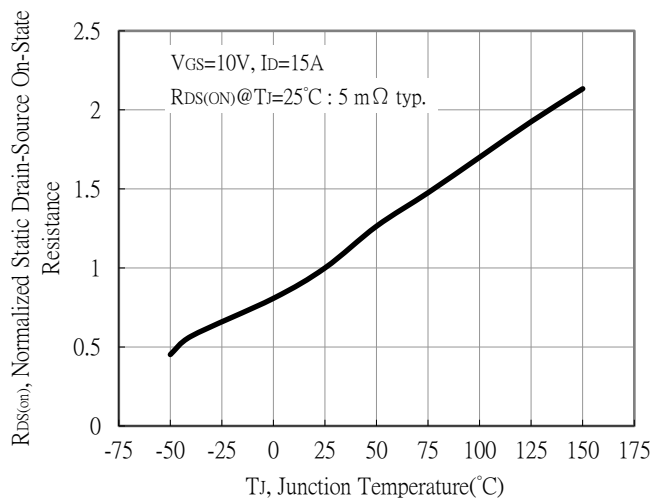
Body Diode Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

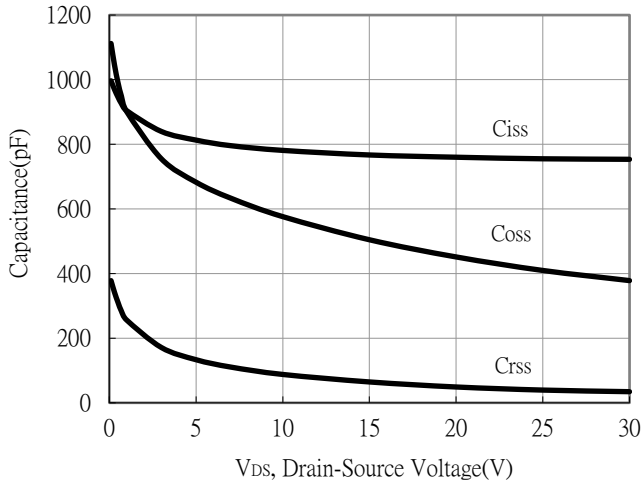


Drain-Source On-State Resistance vs Junction Temperature

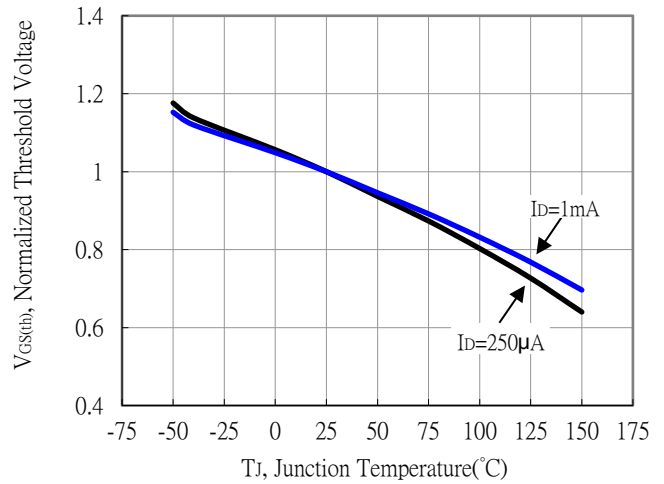


Typical Characteristics (Cont.) : Q2(N-channel)

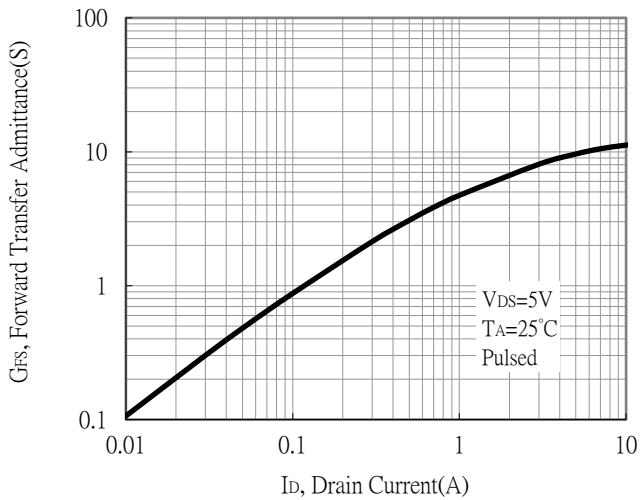
Capacitance vs Drain-to-Source Voltage



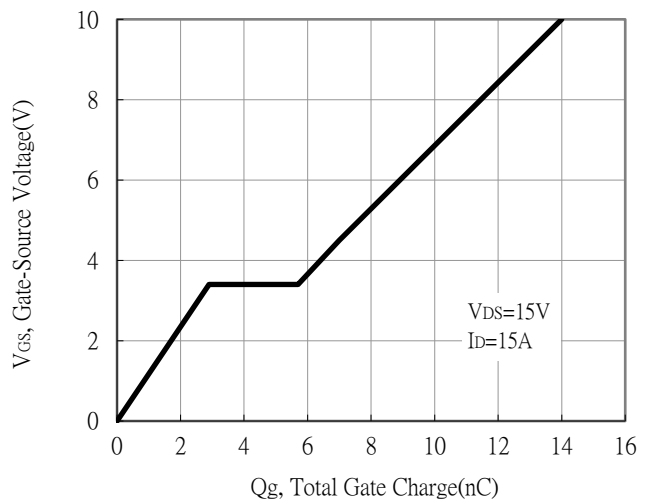
Threshold Voltage vs Junction Temperature



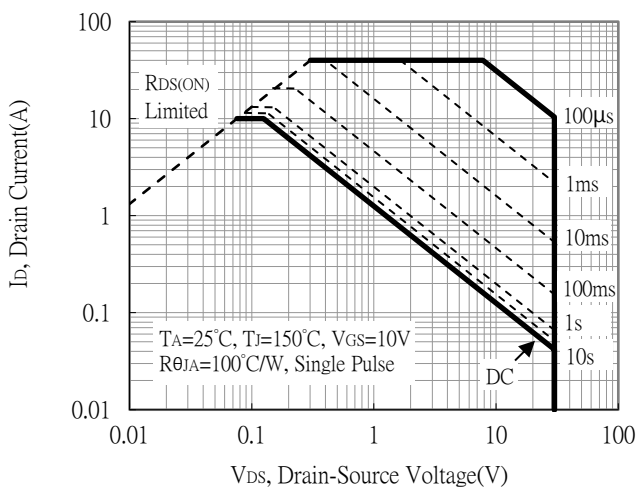
Forward Transfer Admittance vs Drain Current



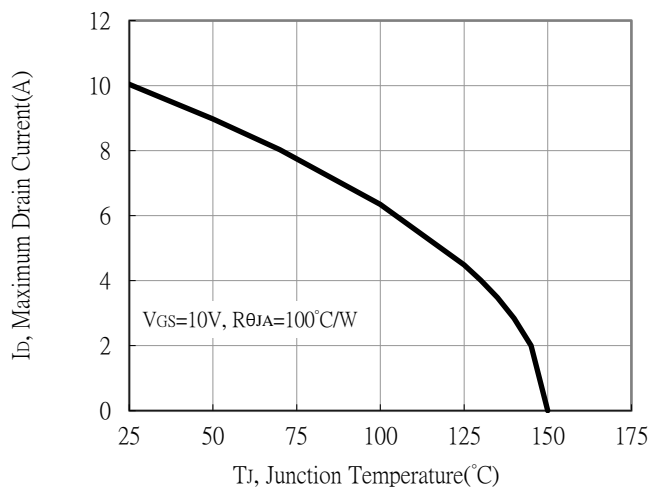
Gate Charge Characteristics



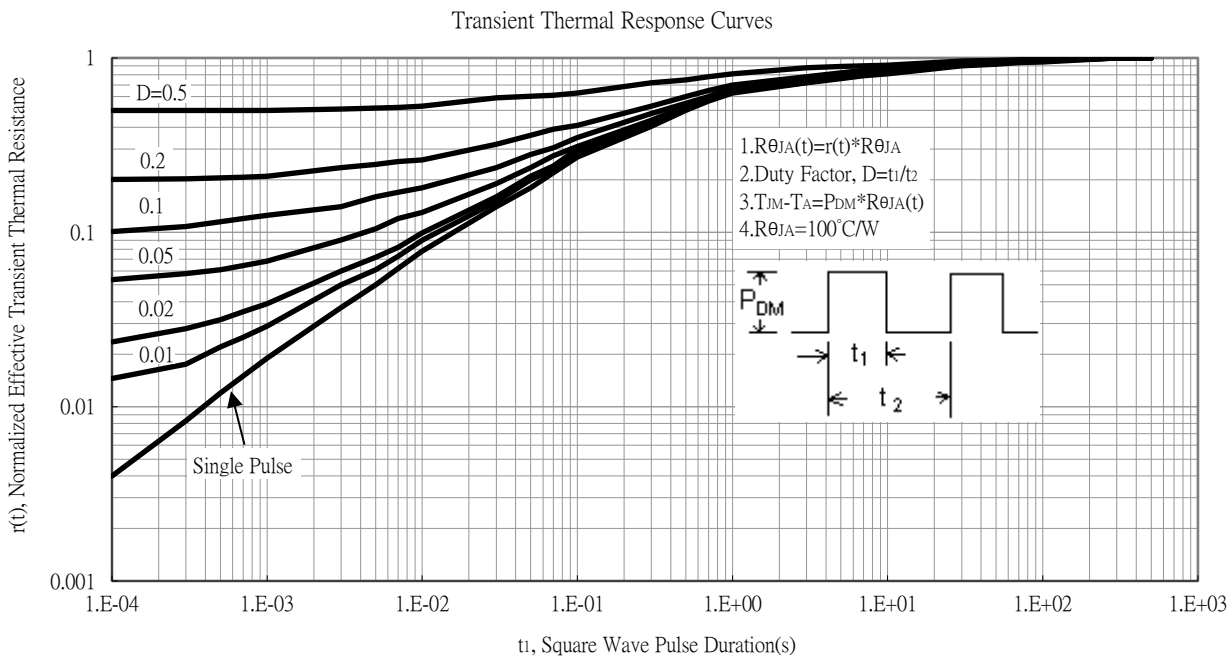
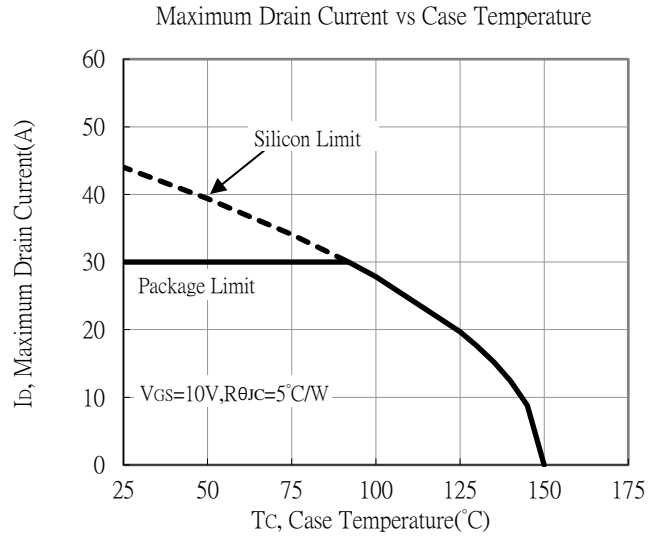
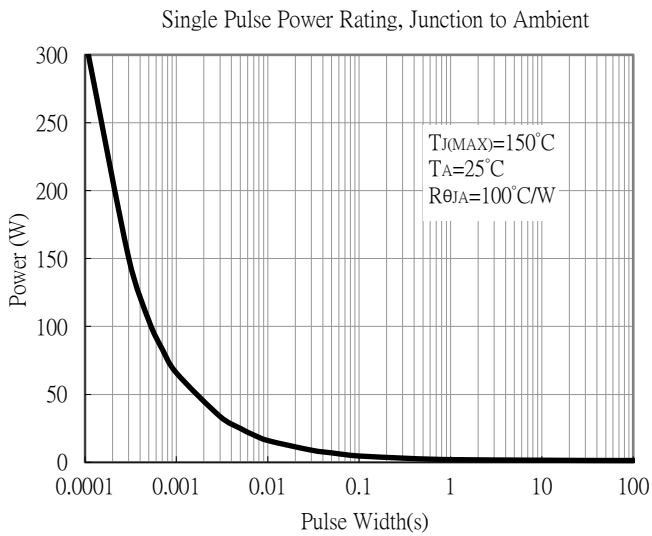
Maximum Safe Operating Area



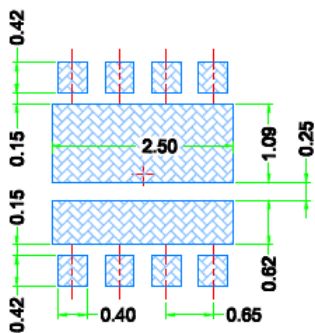
Maximum Drain Current vs Junction Temperature



Typical Characteristics (Cont.) : Q2(P-channel)

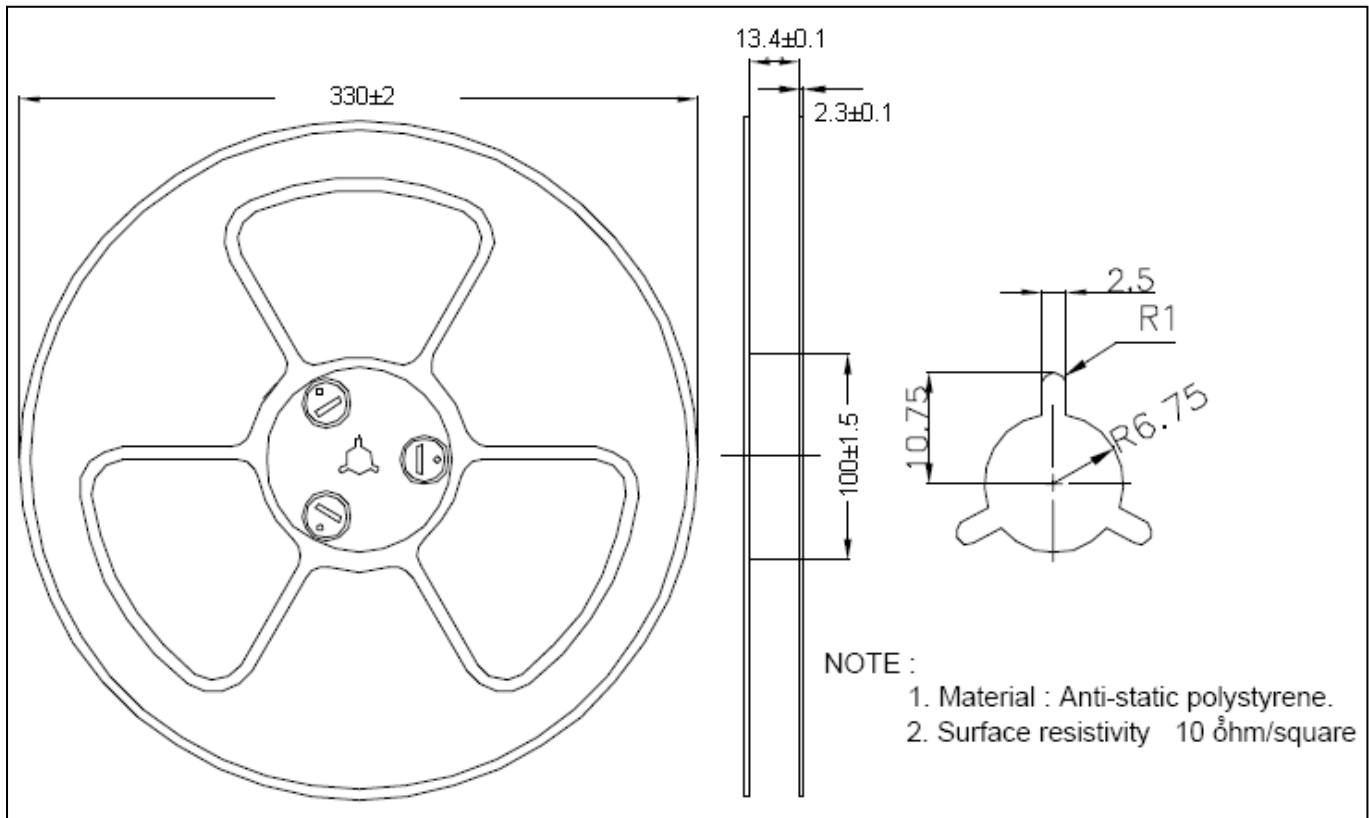


Recommended Soldering Footprint

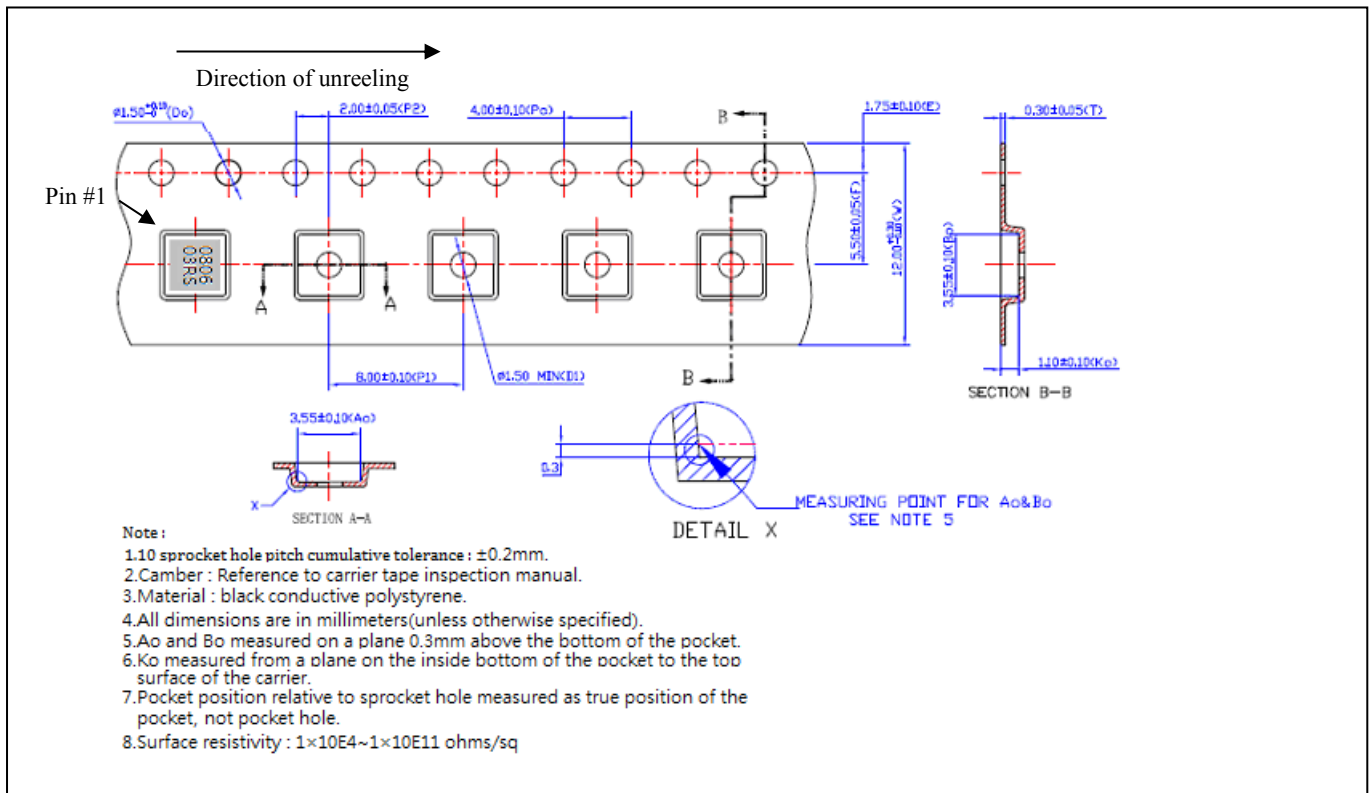


unit : mm

Reel Dimension



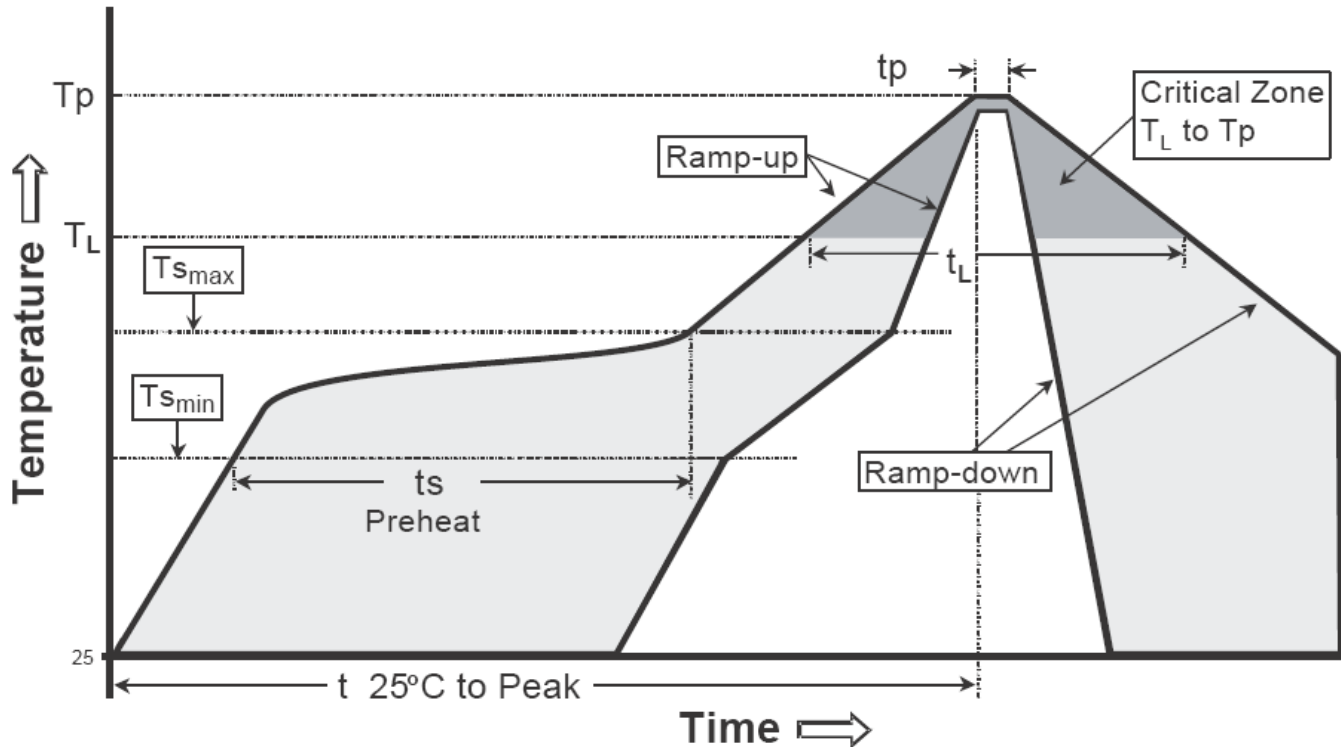
Carrier Tape



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

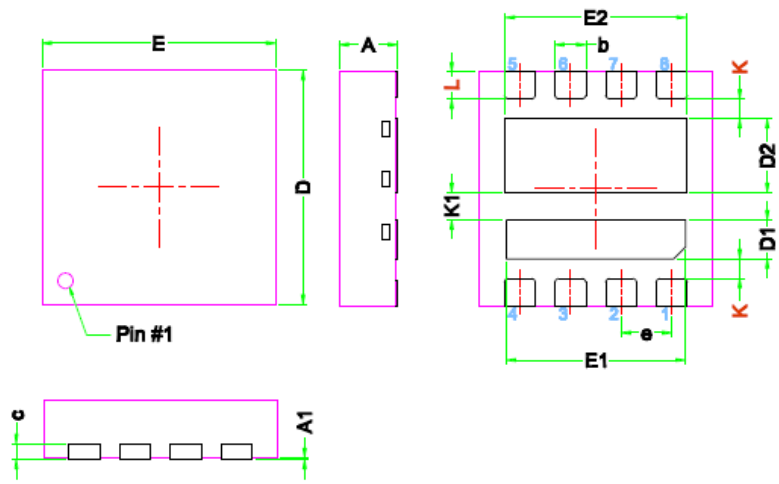
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

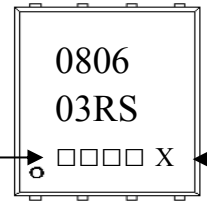
Note : All temperatures refer to topside of the package, measured on the package body surface.

DFN3x3 Dimension



Marking:

G2 S2 S2 S2



G1 D1 D1 D1

Assembly site code:
blank→site 1
G→site 2

Date Code →

Note : 1.All dimensions are in mm.
 2.Dimensions are not inclusive burrs and mold flash.

8-Lead DFN3x3 Plastic Package
 CYStek Package Code: V8

Date Code(counting from left to right) :
 1st code: year code, the last digit of Christian year
 2nd code : month code, Jan→A, Feb→B, Mar→C, Apr→D
 May→E, Jun→F, Jul→G, Aug→H, Sep→J,
 Oct→K, Nov→L, Dec→M
 3rd and 4th codes : production serial number, 01~99

DIM	Millimeters		Inches		DIM	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.70	0.80	0.028	0.032	E	2.90	3.10	0.114	0.122
A1	0.00	0.05	0.000	0.002	E1	2.20	2.40	0.087	0.094
b	0.35	0.45	0.014	0.018	E2	2.20	2.45	0.087	0.096
c	0.20	REF	0.008	REF	e	0.55	0.75	0.008	0.030
D	2.90	3.10	0.114	0.122	K	0.15	0.35	0.006	0.014
D1	0.40	0.60	0.016	0.024	K1	0.25	0.45	0.010	0.018
D2	0.85	1.05	0.033	0.041	L	0.27	0.40	0.011	0.016

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead: pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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